


<b>Search Notes</b> 	<b>Application/Control No.</b> 10813818	<b>Applicant(s)/Patent Under Reexamination</b> WANG ET AL.
	<b>Examiner</b> Hung, Yubin	<b>Art Unit</b> 2624

SEARCHED			
Class	Subclass	Date	Examiner
382	173, 176	6/8/08	YH
707	2-4, 104.1	6/8/08	YH
715	501.1, 513	6/8/08	YH

SEARCH NOTES			
Search Notes		Date	Examiner
EAST text search (USPGPUB, USPAT, EPO, JPO, DERWENT, IBM-TDB)		9/28/08	YH
Inventor and assignee search		12/21/07	YH
ACM		12/21/07	YH
IEEE Xplore		12/21/07	YH
SPIE		12/21/07	YH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/YUBIN HUNG/ Primary Examiner.Art Unit 2624
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